

Notice of References Cited

Application/Control No.

10/774,321

Applicant(s)/Patent Under
Reexamination
LIN ET AL.

Examiner

Fadey S. Jabr

Art Unit

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-2004/0261070 A1	12-2004	Miller et al.	717/170
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